

SuperFET**

FCB11N60 600V N-Channel MOSFET

Features

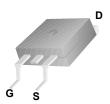
- 650V @T_{.I} = 150°C
- Typ. $R_{DS(on)} = 0.32\Omega$
- Ultra low gate charge (typ. Q_g = 40nC)
- Low effective output capacitance (typ. Coss.eff = 95pF)
- 100% avalanche tested
- · RoHS Compliant

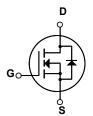


Description

SuperFETTM is, Fairchild's proprietary, new generation of high voltage MOSFET family that is utilizing an advanced charge balance mechanism for outstanding low on-resistance and lower gate charge performance.

This advanced technology has been tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate and higher avalanche energy. Consequently, SuperFET is very suitable for various AC/DC power conversion in switching mode operation for system miniaturization and higher efficiency.





Absolute Maximum Ratings

Symbol	Parameter		FCB11N60	Unit	
V _{DSS}	Drain-Source Voltage		600	V	
I _D	Drain Current - Continuous (T _C = 25°C) - Continuous (T _C = 100°C)		11 7	A A	
I _{DM}	Drain Current - Pulsed	(Note 1)	33	А	
V _{GSS}	Gate-Source voltage		± 30	V	
E _{AS}	Single Pulsed Avalanche Energy (No		340	mJ	
I _{AR}	Avalanche Current	(Note 1)	11	А	
E _{AR}	Repetitive Avalanche Energy (Note 1)		12.5	mJ	
dv/dt	Peak Diode Recovery dv/dt (Note 3)		4.5	V/ns	
P _D	Power Dissipation (T _C = 25°C) - Derate above 25°C		125 1.0	W W/°C	
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C	
T _L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		300	°C	

Thermal Characteristics

Symbol	Parameter	FCB11N60	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	1.0	°C/W
R _{θJA} *	Thermal Resistance, Junction-to-Ambient*	40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	°C/W

^{*} When mounted on the minimum pad size recommended (PCB Mount)

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FCB11N60	FCB11N60	D ² -PAK	330mm	24m	800

Electrical Characteristics T_C = 25°C unless otherwise noted

Symbol	Parameter	Conditions	Min	Тур	Max	Units
Off Charac	teristics			ı		
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0V$, $I_D = 250\mu A$, $T_J = 25^{\circ}C$	600			V
		V _{GS} = 0V, I _D = 250μA, T _J = 150°C		650		V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C		0.6		V/°C
BV _{DS}	Drain-Source Avalanche Breakdown Voltage	V _{GS} = 0V, I _D = 11A		700		V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 600V, V _{GS} = 0V V _{DS} = 480V, T _C = 125°C			1 10	μA μA
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30V, V _{DS} = 0V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30V, V _{DS} = 0V	-		-100	nA
On Charac	teristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250\mu A$	3.0		5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10V, I _D = 5.5A		0.32	0.38	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 40V, I _D = 5.5A (Note 4)	-	9.7		S
Dynamic C	Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = 25V$, $V_{GS} = 0V$,		1148	1490	pF
C _{oss}	Output Capacitance	f = 1.0MHz		671	870	pF
C _{rss}	Reverse Transfer Capacitance		ı	63		pF
C _{oss}	Output Capacitance	$V_{DS} = 480V, V_{GS} = 0V, f = 1.0MHz$		35		pF
Coss eff.	Effective Output Capacitance	V_{DS} = 0V to 400V, V_{GS} = 0V	1	95		pF
Switching	Characteristics					
t _{d(on)}	Turn-On Delay Time	V _{DD} = 300V, I _D = 11A		34	80	ns
t _r	Turn-On Rise Time	$R_G = 25\Omega$		98	205	ns
t _{d(off)}	Turn-Off Delay Time			119	250	ns
t _f	Turn-Off Fall Time	(Note 4, 5)		56	120	ns
Qg	Total Gate Charge	V _{DS} = 480V, I _D = 11A	-	40	52	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10V	-	7.2		nC
Q _{gd}	Gate-Drain Charge	(Note 4, 5)	-	21		nC
Drain-Sour	rce Diode Characteristics and Maximur	n Ratings				
I _S	Maximum Continuous Drain-Source Dio	de Forward Current			11	Α
I _{SM}	Maximum Pulsed Drain-Source Diode F	orward Current	-		33	Α
V_{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0V, I _S = 11A	-		1.4	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _S = 11A	-	390		ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$ (Note 4)		5.7		μС

Notes

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. I_{AS} = 5.51A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25°C
- 3. I_{SD} \leq 11A, di/dt \leq 200A/µs, V_{DD} \leq BV_DSS, Starting T_J = 25°C
- 4. Pulse Test: Pulse width $\leq 300 \mu s, \ \text{Duty Cycle} \leq 2\%$
- 5. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

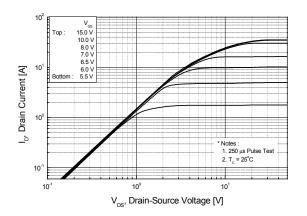


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

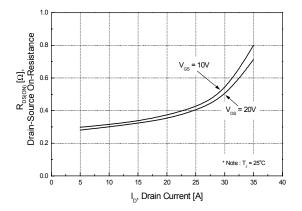


Figure 2. Transfer Characteristics

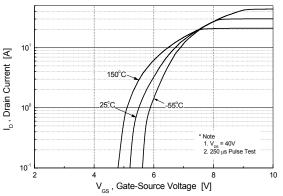


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperatue

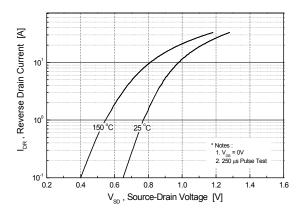


Figure 5. Capacitance Characteristics

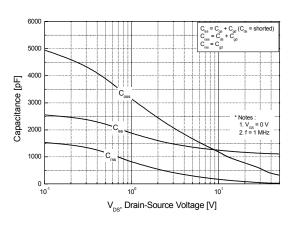
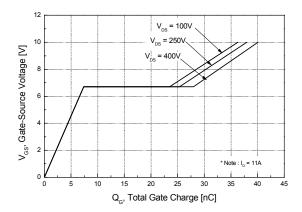


Figure 6. Gate Charge Characteristics



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Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

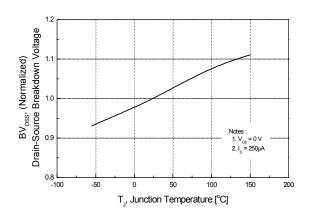


Figure 8. On-Resistance Variation vs. Temperature

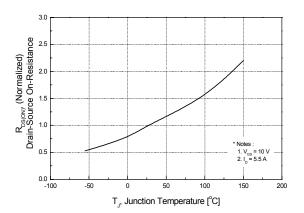


Figure 9. Maximum Safe Operating Area

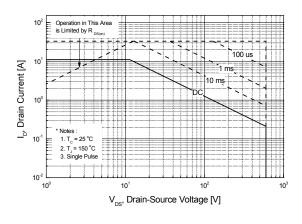


Figure 10. Maximum Drain Current vs. Case Temperature

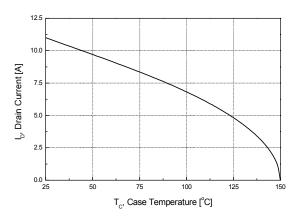
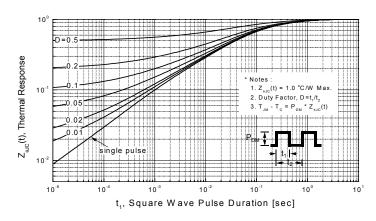
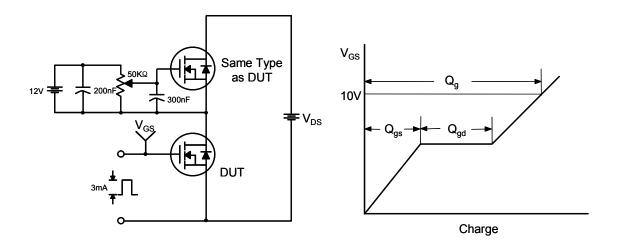


Figure 11. Transient Thermal Response Curve

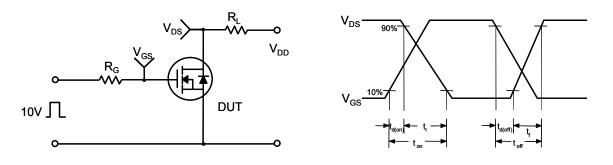


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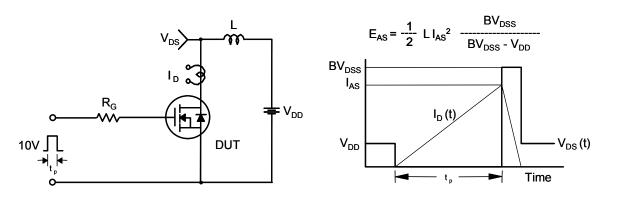
Gate Charge Test Circuit & Waveform



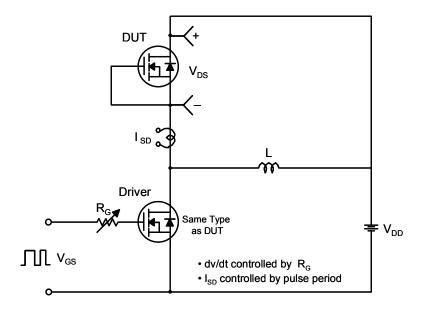
Resistive Switching Test Circuit & Waveforms

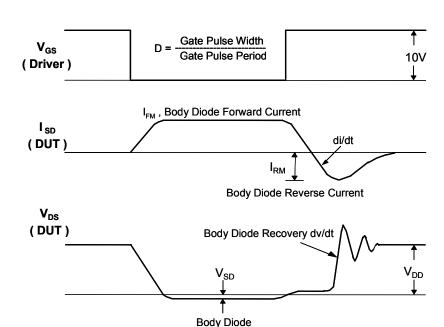


Unclamped Inductive Switching Test Circuit & Waveforms



Peak Diode Recovery dv/dt Test Circuit & Waveforms

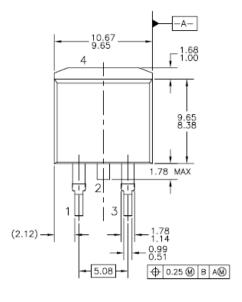


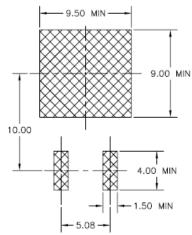


Forward Voltage Drop

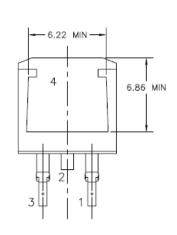
Mechanical Dimensions

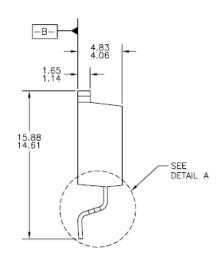
D²-PAK

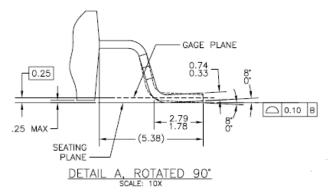




LAND PATTERN RECOMMENDATION







Dimensions in Millimeters





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